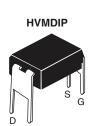
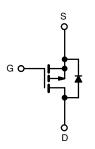
Vishay Siliconix

Power MOSFET





P-Channel MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	-60				
R _{DS(on)} (Ω)	V _{GS} = -10 V	0.50			
Q _g (Max.) (nC)	12				
Q _{gs} (nC)	3.8				
Q _{gd} (nC)	5.1				
Configuration	Single				

FEATURES

- Dynamic dV/dt rating
- Repetitive avalanche rated
- For automatic Insertion
- End stackable
- P-channel
- 175 °C operating temperature
- · Fast switching
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain servers as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION				
Package	HVMDIP			
Lead (Pb)-free	IRFD9014PbF			

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)							
PARAMETER			SYMBOL	LIMIT	UNIT		
Drain-source voltage			V _{DS}	-60	.,		
Gate-source voltage			V _{GS}	± 20	V		
Continuous drain current	V _{GS} at 10 V	T _A = 25 °C T _A = 100 °C	- I _D	-1.1			
Continuous drain current		T _A = 100 °C		-0.80	Α		
Pulsed drain current ^a			I _{DM}	-8.8			
Linear derating factor				0.0083	W/°C		
Single pulse avalanche energy b			E _{AS}	140	mJ		
Repetitive avalanche current a	I _{AR}	-1.1	А				
Repetitive avalanche energy ^a			E _{AR}	0.13	mJ		
Maximum power dissipation $T_A = 25 ^{\circ}C$		P_{D}	1.3	W			
Peak diode recovery dV/dt ^c			dV/dt	-4.5	V/ns		
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +175	- °C		
Soldering recommendations (peak temperature)	For 10 s			300 ^d			

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = -25 V, starting T_J = 25 °C, L = 33 mH, R_g = 25 Ω , I_{AS} = -2.2 A (see fig. 12)
- c. $I_{SD} \le -6.7$ A, $dI/dt \le 90$ A/ μ s, $V_{DD} \le V_{DS}$, $T_{J} \le 175$ °C
- d. 1.6 mm from case



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THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	TYP.	MAX.	UNIT			
Maximum Junction-to-Ambient	R _{thJA}	-	120	°C/W			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = -1 mA	-	-0.060	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	· V _{GS} , I _D = -250 μA	-2.0	-	-4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V		-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		= -60 V, V _{GS} = 0 V	-	-	-100	μA
Duris Os assessor Os Olata Basistana			', V _{GS} = 0 V, T _J = 150 °C	-	-	-500	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = -10 V	$I_D = -0.66 \text{ Ab}$	- 0.70	-	0.50	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	-25 V, I _D = -0.66 A ^b	0.70	-	_	S
Dynamic		1		l	070		
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V}, \\ V_{DS} = -25 \text{ V}, \\ f = 1.0 \text{ MHz, see fig. 5}$		-	270	_	pF
Output Capacitance	C _{oss}			-	170	-	
Reverse Transfer Capacitance	C _{rss}			-	31	-	
Total Gate Charge	Qg	<u> </u>	$I_D = -6.7 \text{ A}, V_{DS} = -48 \text{ V},$	-	-	12	
Gate-Source Charge	Q _{gs}	V _{GS} = -10 V	$V_{GS} = -10 \text{ V}$ see fig. 6 and 13 ^b		-	3.8	nC
Gate-Drain Charge	Q _{gd}			-	-	5.1	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = -30 \text{ V, } I_D = -6.7 \text{ A,}$ $R_g = 24 \ \Omega, \ R_D = 4.0 \ \Omega, \ \text{see fig. } 10^b$		-	11	-	ns
Rise Time	t _r			-	63	_	
Turn-Off Delay Time	t _{d(off)}			-	10	-	
Fall Time	t _f				31	-	
Internal Drain Inductance	L_D	6 mm (0.25	Between lead, 6 mm (0.25") from		4.0	-	nH
Internal Source Inductance	L_{S}	package and center of die contact		-	6.0	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	-1.1	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	-8.8	- A
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = -1.1 A, V _{GS} = 0 V ^b		-	-	-5.5	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = -6.7 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s}^b$		-	80	160	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.096	0.19	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)					L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

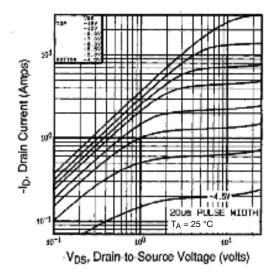


Fig. 1 - Typical Output Characteristics, T_A = 25 °C

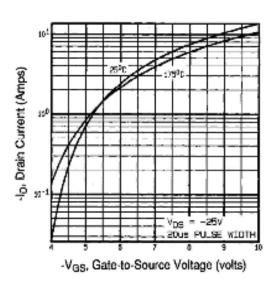


Fig. 2 - Typical Transfer Characteristics

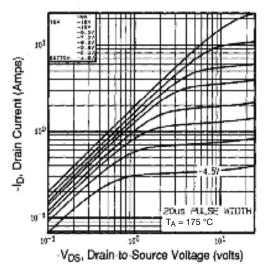


Fig. 1 - Typical Output Characteristics, $T_A = 175$ °C

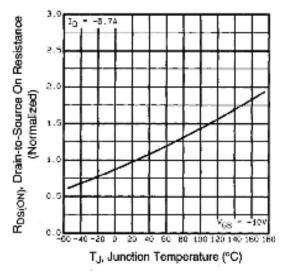


Fig. 3 - Normalized On-Resistance vs. Temperature



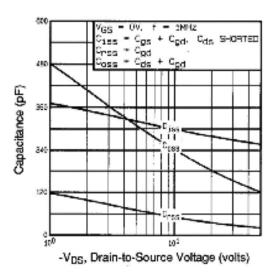


Fig. 4 - Typical Capacitance vs. Drain-to-Source Voltage

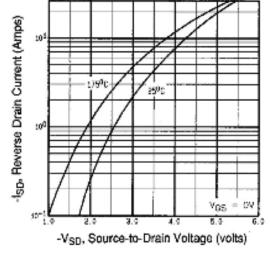


Fig. 6 - Typical Source-Drain Diode Forward Voltage

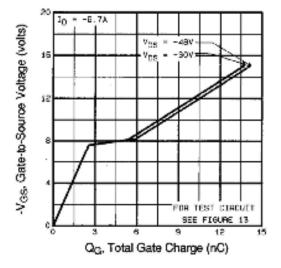


Fig. 5 - Typical Gate Charge vs. Gate-to-Source Voltage

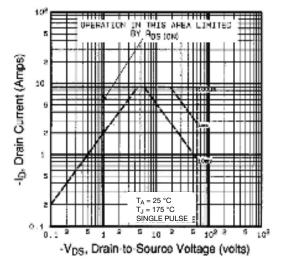


Fig. 7 - Maximum Safe Operating Area



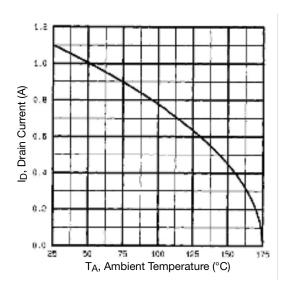


Fig. 8 - Maximum Drain Current vs. Ambient Temperature

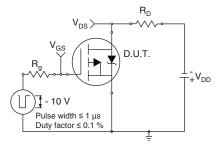


Fig. 10a - Switching Time Test Circuit

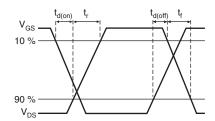


Fig. 10b - Switching Time Waveforms

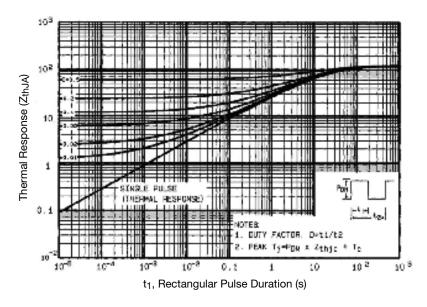


Fig. 9 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



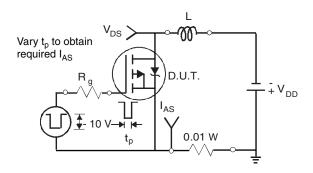


Fig. 12a - Unclamped Inductive Test Circuit

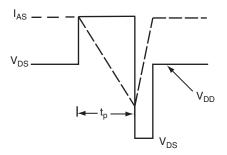


Fig. 12b - Unclamped Inductive Waveforms

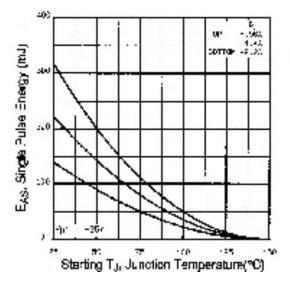


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

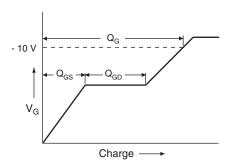


Fig. 13a - Basic Gate Charge Waveform

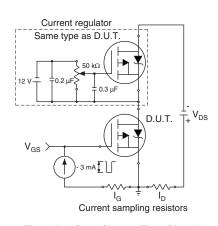
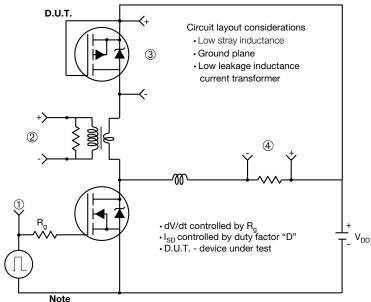


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver

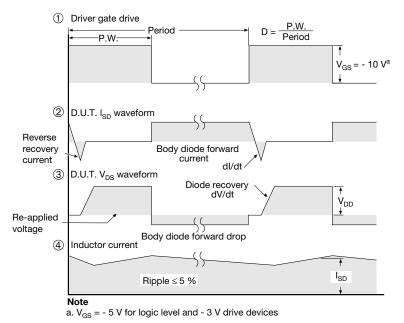


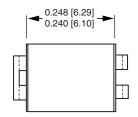
Fig. 10 - For P-Channel

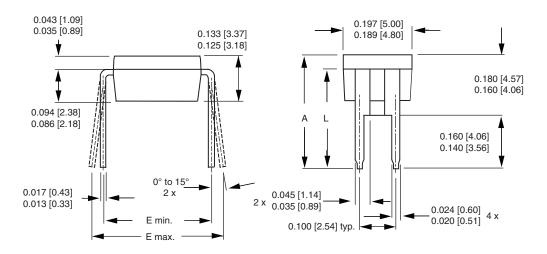
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Vishay Siliconix

HVM DIP (High voltage)





	INCHES		MILLIMETERS	
DIM.	MIN.	MAX.	MIN.	MAX.
A	0.310	0.330	7.87	8.38
E	0.300	0.425	7.62	10.79
L	0.270	0.290	6.86	7.36

ECN: X10-0386-Rev. B, 06-Sep-10

DWG: 5974

Note

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.

Document Number: 91361 Revision: 06-Sep-10





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